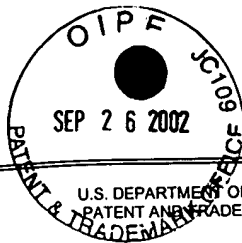




Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 193792US25		SERIAL NO. 09/730,592	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT James M. FITZPATRICK			
				FILING DATE December 7, 2000		GROUP 2161	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
AFC		AW M. NEGIN, et al., Computer (online), vol. 33, no. 2, pages 2-7, "AN IRIS BIOMETRIC SYSTEM FOR PUBLIC AND PERSONAL USE", February 2000					
		AX					
		AY					
		AZ					
					<input type="checkbox"/> Additional References sheet(s) attached		
Examiner <i>Diana Charles</i>					Date Considered <i>2/2/04</i>		
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

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## LIST OF REFERENCES CITED BY APPLICANT

APPLICANT

James M. FITZPATRICK

FILING DATE

December 7, 2000

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2161

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EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
DFC	AA	4,992,940	02/12/91	R. E. DWORKIN			
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## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

DFC	AW	M. NEGIN, et al., Computer (online), vol. 33, no. 2, pages 2-7, "AN IRIS BIOMETRIC SYSTEM FOR PUBLIC AND PERSONAL USE", February 2000 (page 5 will be filed later)
DFC	AX	Airaffair.com (online), 2 pages, "THE AIR AFFAIR FUEL PRICE DATABASE", June 14, 2000
DFC	AY	Trak Systems (online), 10 pages, "TRAK SYSTEMS RECORDTRAK SOFTWARE INFORMATION", 2000
	AZ	

☐ Additional References sheet(s) attached

Examiner

Date Considered

2/2/01

\*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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U.S. PATENT DOCUMENTS

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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

AW	M. NEGIN, et al., Computer (online), vol. 33, no. 2, pages 2-7, "AN IRIS BIOMETRIC SYSTEM FOR PUBLIC AND PERSONAL USE", February 2000
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AY	
AZ	

Examiner

*Diana Charles*

☐ Additional References sheet(s) attached

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